Notice of References Cited Application/Control No. 10/563,756 Examiner Khanh T. Nguyen Applicant(s)/Patent Under Reexamination TANAKA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,399,230	06-2002	Tormey et al.	428/702
*	В	US-4,251,397	02-1981	Scheiber, David H.	252/519.34
*	С	US-6,428,914	08-2002	Nagano et al.	313/509
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-		·	
	I	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 0132810	07-1984	EPO	Hormadaly, Jacob	C03C 03/64
	0					
	Р					
	Q					
	R					
	s					
	Т				·	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.